## Application/Control No. Applicant(s)/Patent Under Reexamination 10/708,829 BEENAU ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Nam V. Nguyen 2612 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,424,249 07-2002 Houvener, Robert C. 340/5.82 Α 194/205 10-2003 Griswold et al. US-6,629,591 В 705/16 US-2002/0169673 11-2002 Prorock et al. С US-D US-E US-F US-G US-Н US-1 US-US-Κ

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